



GL20J80A47

GL Silicon N-Channel Super-Junction Power MOSFET

General Description:

GL20J80A47 the silicon N-channel Enhanced VDMOSFETS, is obtained by the self-aligned Super-junction Technology which reduce the conduction loss, improve switching performance and enhance the avalanche energy. The transistor can be used in various power switching circuit for system miniaturization and higher efficiency. The package form is TO-247, which accords with the RoHS standard.

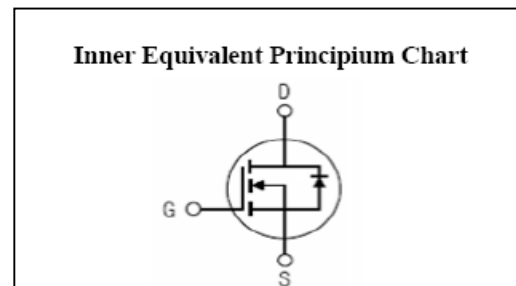
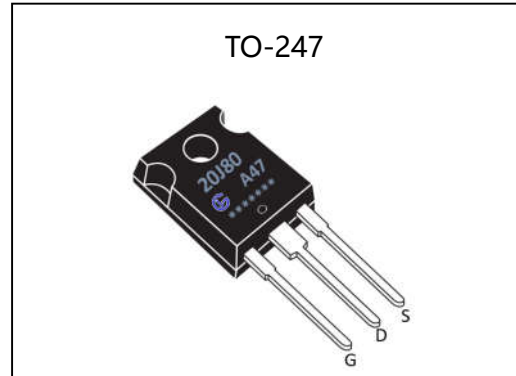
| | | |
|-----------------------------|------|----------|
| V_{DSS} | 800 | V |
| I_D | 20 | A |
| $P_D(T_C=25^\circ\text{C})$ | 166 | W |
| $R_{DS(ON)TYP}$ | 0.21 | Ω |

Features:

- Fast Switching
- Low Gate Charge and Rdson
- Low Reverse transfer capacitances
- 100% Single Pulse avalanche energy Test

Applications:

- Switch Mode Power Supply(SMPS)
- Uninterruptible Power Supply(UPS)
- Power Factor Correction(PFC)



Absolute (Tc= 25°C unless otherwise specified):

| Symbol | Parameter | Rating | Units |
|----------------|--|-----------------|------------------|
| V_{DSS} | Drain-to-Source Voltage | 800 | V |
| I_D | Continuous Drain Current | 20 | A |
| I_{DM}^{a1} | Pulsed Drain Current | 80 | A |
| V_{GS} | Gate-to-Source Voltage | ± 30 | V |
| E_{AS}^{a2} | Single Pulse Avalanche Energy | 490 | mJ |
| P_D | Power Dissipation | 166 | W |
| T_J, T_{stg} | Operating Junction and Storage Temperature Range | 150, -55 to 150 | $^\circ\text{C}$ |
| T_L | Maximum Temperature for Soldering | 300 | $^\circ\text{C}$ |

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" may cause permanent damage to the device.

Thermal Characteristics

| Symbol | Parameter | Typ. | Units |
|-----------------|---------------------|------|---------------------------|
| $R_{\theta JC}$ | Junction-to-Case | 0.75 | $^\circ\text{C}/\text{W}$ |
| $R_{\theta JA}$ | Junction-to-Ambient | 62 | $^\circ\text{C}/\text{W}$ |



GL20J80A47

GL Silicon N-Channel Super-Junction Power MOSFET

Electrical Characteristics (Tc= 25°C unless otherwise specified):

| OFF Characteristics | | | | | | |
|---------------------|-----------------------------------|---|--------|------|------|-------|
| Symbol | Parameter | Test Conditions | Rating | | | Units |
| | | | Min. | Typ. | Max. | |
| V _{DSS} | Drain to Source Breakdown Voltage | V _{GS} =0V, I _D =250μA | 800 | -- | -- | V |
| I _{DSS} | Drain to Source Leakage Current | V _{DS} =800V, V _{GS} =0V, T _a = 25°C | -- | -- | 1.0 | μA |
| | | V _{DS} =640V, V _{GS} =0V, T _a =150°C | -- | -- | 250 | |
| I _{GSS(F)} | Gate to Source Forward Leakage | V _{GS} = +30V | -- | -- | 100 | nA |
| I _{GSS(R)} | Gate to Source Reverse Leakage | V _{GS} = -30V | -- | -- | -100 | nA |

| ON Characteristics | | | | | | |
|-----------------------------------|-------------------------------|--|--------|------|------|-------|
| Symbol | Parameter | Test Conditions | Rating | | | Units |
| | | | Min. | Typ. | Max. | |
| R _{DS(ON)} ^{a3} | Drain-to-Source On-Resistance | V _{GS} = 10V, I _D =10A | -- | 0.21 | 0.25 | Ω |
| V _{GS(TH)} | Gate Threshold Voltage | V _{DS} =V _{GS} , I _D =250μA | 2.0 | -- | 3.0 | V |

| Dynamic Characteristics | | | | | | |
|-------------------------------|------------------------------|---|--------|------|------|-------|
| Symbol | Parameter | Test Conditions | Rating | | | Units |
| | | | Min. | Typ. | Max. | |
| g _{fs} ^{a3} | Forward Transconductance | V _{DS} = 10V, I _D =20A | -- | 18 | -- | S |
| C _{iss} | Input Capacitance | V _{GS} =0V, V _D =25V f= 1.0MHz | -- | 1300 | -- | pF |
| C _{oss} | Output Capacitance | | -- | 380 | -- | |
| C _{rss} | Reverse Transfer Capacitance | | -- | 22 | -- | |

| Resistive Switching Characteristics | | | | | | |
|-------------------------------------|-----------------------------------|---|--------|------|------|-------|
| Symbol | Parameter | Test Conditions | Rating | | | Units |
| | | | Min. | Typ. | Max. | |
| t _{d(ON)} | Turn-on Delay Time | V _{DD} =400V, I _D =20A, V _{GS} =10V R _g =25Ω | -- | 40 | -- | ns |
| t _r | Rise Time | | -- | 21 | -- | |
| t _{d(OFF)} | Turn-Off Delay Time | | -- | 140 | -- | |
| t _f | Fall Time | | -- | 22 | -- | |
| Q _g | Total Gate Charge | I _D =40A, V _{DD} =480V V _{GS} =0 to 10V | -- | 28 | -- | nC |
| Q _{gs} | Gate to Source Charge | | -- | 7 | -- | |
| Q _{gd} | Gate to Drain ("Miller") Charge | | -- | 12 | -- | |



GL20J80A47

GL Silicon N-Channel Super-Junction Power MOSFET

Source-Drain Diode Characteristics

| Symbol | Parameter | Test Conditions | Rating | | | Units |
|----------|--|----------------------------|--------|------|------|---------|
| | | | Min. | Typ. | Max. | |
| I_S | Continuous Source Current (Body Diode) | | -- | -- | 20 | A |
| I_{SM} | Maximum Pulsed Current (Body Diode) | | -- | -- | 80 | A |
| V_{SD} | Diode Forward Voltage | $I_S=20A, V_{GS}=0V$ | -- | -- | 1.5 | V |
| t_{rr} | Reverse Recovery Time | $I_S=20A, V_{GS}=0V$ | -- | 440 | -- | ns |
| Q_{rr} | Reverse Recovery Charge | $I_S=I_F, d_i/d_t=100A/us$ | -- | 5.0 | -- | μC |

Pulse width $t_p \leq 380\mu s, \delta \leq 2\%$

^{a1}: Repetitive rating; pulse width limited by maximum junction temperature

^{a2}: $I_{AS}=5A, V_{DD}=60V, R_G=25\Omega$, Starting $T_J=25^\circ C$

^{a3}: Pulse Test: Pulse width $\leq 380\mu s$, Duty Cycle $\leq 2\%$



GL20J80A47

GL Silicon N-Channel Super-Junction Power MOSFET

Typical Characteristics

Figure 1. Output Characteristics

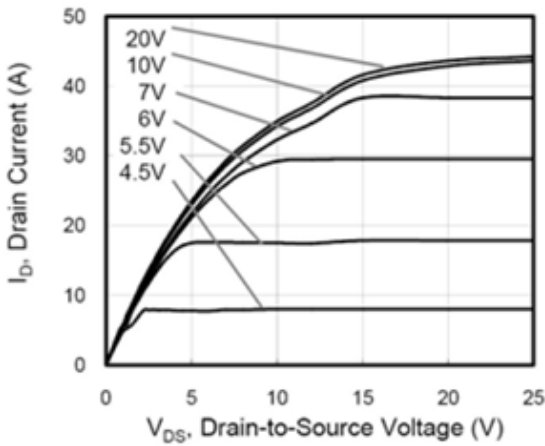


Figure 2. Transfer Characteristics

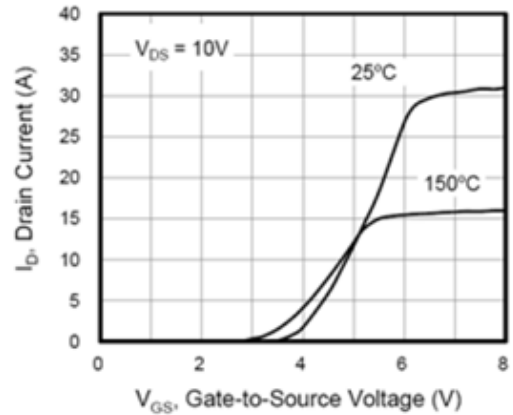


Figure 3. On-Resistance vs. Drain Current

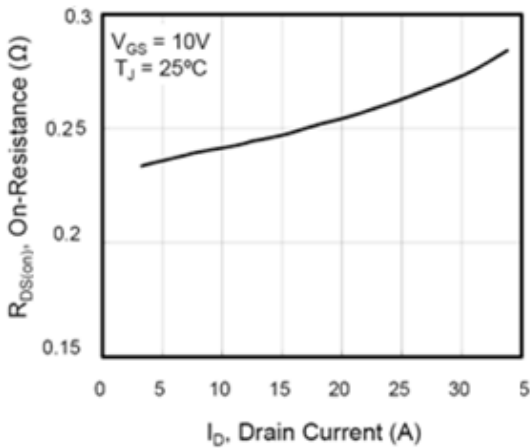


Figure 4. Capacitance

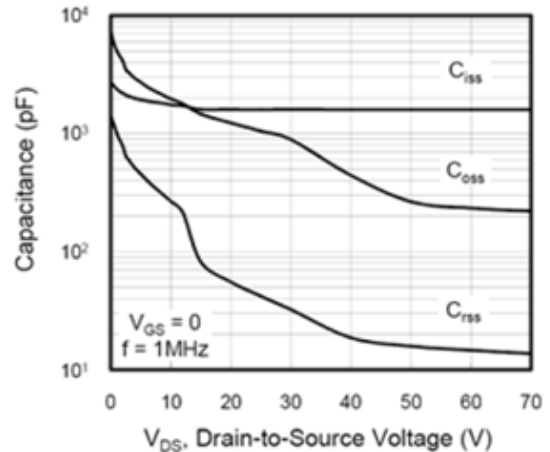


Figure 5. Gate Charge

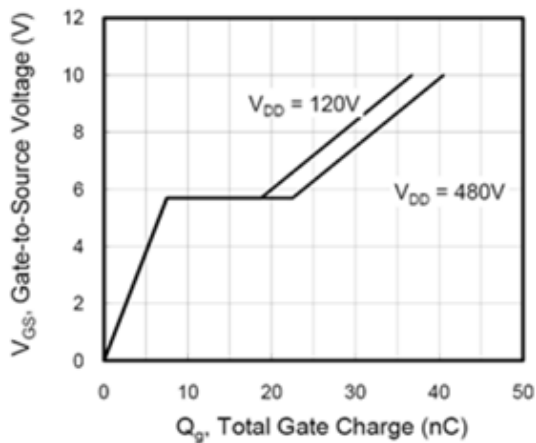
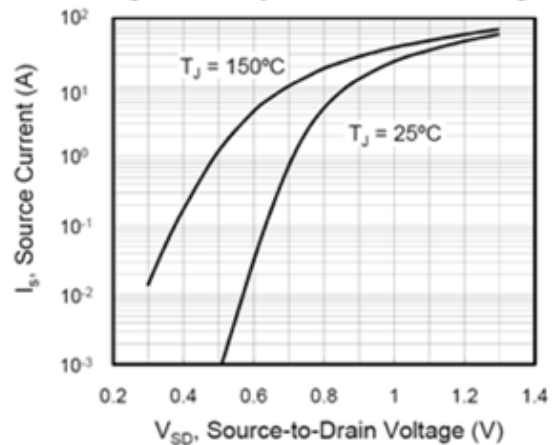


Figure 6. Body Diode Forward Voltage





GL20J80A47

GL Silicon N-Channel Super-Junction Power MOSFET

Figure 7. On-Resistance vs. Junction Temperature

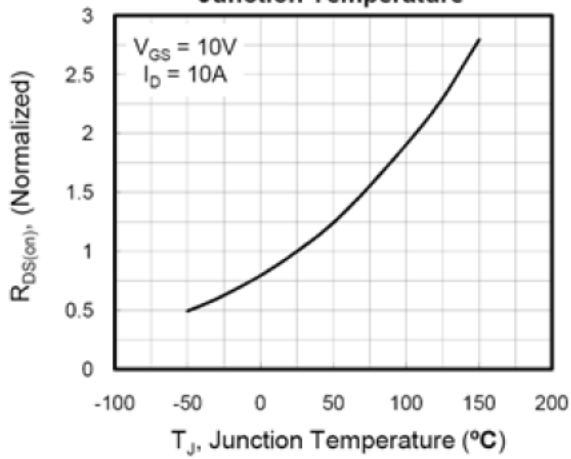


Figure 8. Threshold Voltage vs. Junction Temperature

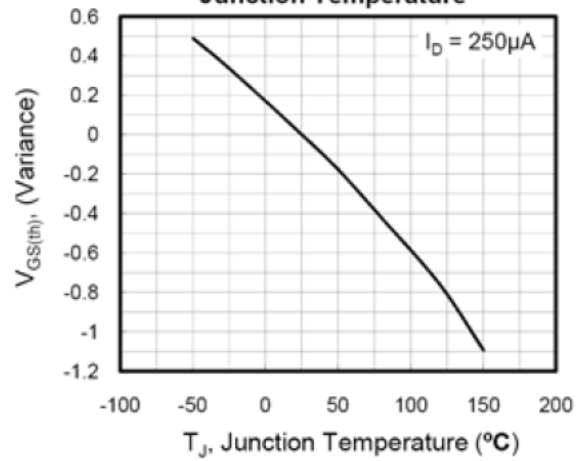


Figure 9. Transient Thermal Impedance TO-3P

